

Model 1750

HIGH SPEED MICRO OHMMETER

- “TRUE-SPEED” high speed testing capability fast and accurate
- 100 nΩ resolution
- Automatic thermal and electromagnetic noise rejection
- Programmable reference currents
- GPIB, RS-232C and RS-422 compatibility

The TEGAM Model 1750 High Speed Micro Ohmmeter is the first breakthrough in high-speed production test since the laser trimmer. The 1750 is the first fully integrated, multi-mode, bus controllable, high-speed, digital ohmmeter designed to outperform all other ohmmeters and enhance the performance of the world's fastest laser trimmers and material handlers.

It's Fast

The 1750 accelerates the high-speed production line with “TRUE-SPEED” performance. In the Fast Mode the 1750 can set-up, zero-out thermal errors, acquire data and make its first reading in less than 12 milliseconds with an accuracy of up to 0.05%! That's “TRUE-SPEED” performance. Subsequent readings are provided every 10 milliseconds at a true rate of 100 readings per second! “TRUE-SPEED” allows you to maximize the speed of your PLC's, material handlers and production line machinery.

The 1750 is fast because it provides speed and accuracy while automatically rejecting thermal and line noise. Patented circuitry eliminates thermal and electromagnetic measurement errors caused by contact between device handlers and the device-under-test. The 1750 rejects DC and AC noise offsets while maintaining its high speed test performance. This unique feature is only found on the TEGAM 1750.

High Speed Micro Ohmmeter

It's High Powered

The 1750's power is in the user's ability to quickly configure it through a selection of standard setup menus. With the 1750 you select your measurement mode, (Resistance, Ohms Comparator or Percentage Comparator), and measurement ranges, (from 2 mΩ to 20 MΩ). You have your choice of reference currents and triggering methods. You can also configure delay times, settling times and automatic thermal and noise rejection.

If you don't need all this flexibility, just hit the AUTO RANGE button and enjoy the ride!

It's Easy to Operate

The 1750 is the state-of-the-art programmable ohm-meter that operates via front-panel or over the bus. Clearly labeled multi-function keys provide front panel control of range selection, reading modes, delays, triggers and measurement HOLD. Clear menu driven options provide easy setup for more sophisticated operation, too! The Front panel includes a manual TRIGGER and HOLD function and HI/GO/LO indicators for the open collector TTL output.

It's Easy to Integrate

The 1750 is unbelievably easy to program. The 1750 contains a full complement of interfaces including IEEE-488, RS-232C and RS-422. To maximize your programming efficiency, each of these interfaces is operated using the same programming command set and front panel indicators to provide continuous status of all operations.

It's Easy to Calibrate

Front panel calibration makes it easy to maintain the 1750 traceability right on the product floor and in less time than it takes to reload a resistor reel.

It's Ready for Any Job

The 1750 provides the speed and accuracy desired for automated production test requirements as well as bench top quality control and inspection applications. Not only is the 1750 perfect for high speed



production test of low resistance electronic components, but the low current capability and “TRUE-SPEED” performance make the 1750 excellent for dry circuit testing of switches, relays and connector contacts without disturbing the device's contact surfaces. 1750 fits most resistor, wire, fuse, thermistor and trimmer testing applications.

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TABLE 1

Full Scale Voltage and Maximum Lead Resistance as a Function of Reference Current

| RANGE | RESOLUTION | REFERENCE CURRENT (AVAILABLE SELECTION) | | | | | | | |
|----------------|-----------------|---|--------|--------|--------|-------------|------------|-----------|--------|
| | | 1 A | 100 mA | 10 mA | 1 mA | 100 μ A | 10 μ A | 1 μ A | 100 nA |
| 2 m Ω | 100 n Ω | 2 mV | | | | | | | |
| 20 m Ω | 1 $\mu\Omega$ | 20 mV | 2 mV | | | | | | |
| 200 m Ω | 10 $\mu\Omega$ | 200 mV | 20 mV | | | | | | |
| 2 Ω | 100 $\mu\Omega$ | | 200 mV | 20 mV | | | | | |
| 20 Ω | 1 m Ω | | | 200 mV | 20 mV | | | | |
| 200 Ω | 10 m Ω | | | 2 V | 200 mV | 20 mV | | | |
| 2 k Ω | 100 m Ω | | | | 2 V | 200 mV | | | |
| 20 k Ω | 1 Ω | | | | | 2 V | 200 mV | | |
| 200 k Ω | 10 Ω | | | | | | 2 V | | |
| 2 M Ω | 100 Ω | | | | | | | 2 V | |
| 20 M Ω | 1 k Ω | | | | | | | | 2 V |

MAX. LEAD RESISTANCE: 500 m Ω 5 Ω 50 Ω 100 Ω 100 Ω 100 Ω 100 Ω 100 Ω

TABLE 2

Delayed Mode Accuracy (In terms of FULL SCALE VOLTAGE)

| FULL SCALE VOLTAGE | (\pm) ACCURACY (18-28°C, 1 yr.) |
|--|-------------------------------------|
| 2 mV | 0.02 % RDG + 5 COUNTS |
| 20 mV | 0.02 % RDG + 4 COUNTS |
| 200 mV | 0.02 % RDG + 2 COUNTS |
| 2 V | 0.02 % RDG + 2 COUNTS |
| 2V (2 M Ω & 20 M Ω ranges) | 0.04 % RDG + 2 COUNTS |

TABLE 3

Temperature Coefficients (In terms of FULL SCALE VOLTAGE)

| FULL SCALE VOLTAGE | (\pm) TEMPERATURE COEFFICIENT (0-18 °C and 28-50 °C) |
|---|--|
| 2 mV | 0.004 % RDG + 1 COUNT |
| 20 mV | 0.004 % RDG + 0.5 COUNTS |
| 200 mV | 0.002 % RDG + 0.1 COUNTS |
| 2V | 0.002 % RDG + 0.1 COUNTS |
| 2 V (2 M Ω & 20 M Ω RANGES) | 0.008 % RDG + 0.5 COUNTS |

FAST MODE ACCURACY is \pm (0.05 % + 5 COUNTS)

Reference Current Modes:

Fast Continuous:

Pulsing reference current (+REF/0), with automatic thermal and noise rejection.

Fast One-Shot:

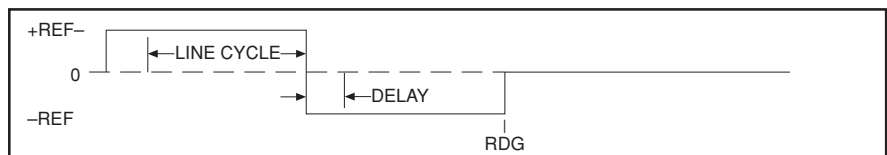
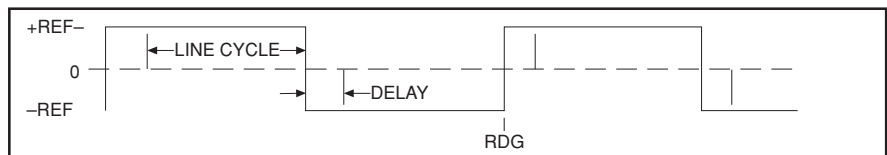
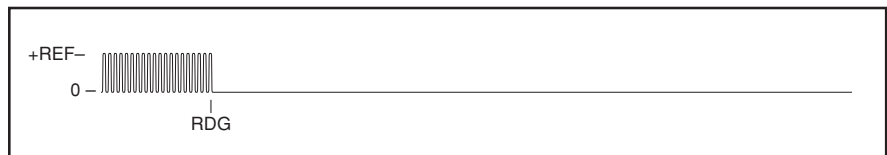
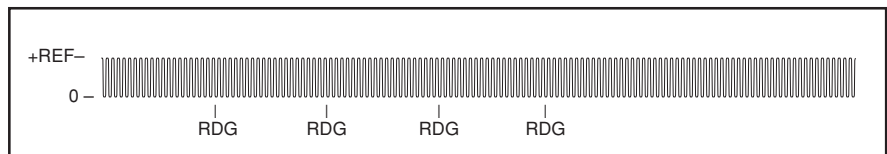
Triggered single cycle of Fast Continuous Mode.

Delayed Continuous:

Alternating reference current (+REF/-REF) with programmable settling time for reference current and line-cycle digitization.

Delayed One-Shot:

Triggered single cycle of Delayed Continuous Mode.



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TABLE 4

Measurement Times:

| FAST MODE v. FULL SCALE VOLTAGE | | | | | DELAYED MODE v. FULL SCALE VOLTAGE | | | |
|---------------------------------|------|-------|---------|---------|------------------------------------|-------|--------|----|
| RANGE | 2 mV | 20 mV | 200 mV | 2 V | 2 mV | 20 mV | 200 mV | 2V |
| 2 mΩ | | | | | D | | | |
| 20 mΩ | | | | | D | D | | |
| 200 mΩ | | | 10 msec | | | D | D | |
| 2 Ω | | | 10 msec | | | D | D | |
| 20 Ω | | | 10 msec | | | D | D | |
| 200 Ω | | | 10 msec | 10 msec | | D | D | D |
| 2 kΩ | | | 10 msec | 10 msec | | | D | D |
| 20 kΩ | | | | 10 msec | | | D | D |
| 200 kΩ | | | | | | | | D |
| 2 MΩ | | | | | | | | D |
| 20 MΩ | | | | | | | | D |

NOTES:

1. Fast Mode available on range and full scale voltage combinations shown, (10 msec).
2. Delayed Mode available on combinations shown, (D).
3. Delayed Mode Measurement Times = 2x (Line Period + Programmed Delay + 1.7 ms Processing Time). e.g. 60 Hz line frequency and 10 ms delay, Time = 55.0 ms.
4. Delays are programmable from 1 ms to 250 ms in 1 ms increments.

TABLE 5

Reading Rates:

| | MEASUREMENT TIMES | READING RATE | TIME TO FIRST READING |
|---------------------|-------------------|--------------|-----------------------|
| FAST MODE | 10 msec | 100 rdg/sec | 12 msec |
| DELAYED MODE | | | |
| Delay = 1 msec | 36 msec | 27 rdg/sec | 38 msec |
| Delay = 5 msec | 45 msec | 22 rdg/sec | 47 msec |
| Delay = 10 msec | 55 msec | 18 rdg/sec | 57 msec |

Miscellaneous

Display Modes

Resistance, Ohms Comparator, % Comparator (Autoranging available in Resistance Mode)

Digital Interfaces

IEEE-488.1, RS-232C, RS-422, TRIGGER IN and READING DONE via BNC connectors

Display

4-1/2 digit alpha numeric readout, 2x16 characters, backlit LCD

Measurement Method

4 - terminal connection to the Device-Under-Test, (DUT)

Input Connector

Heavy duty LEMO type for interface integrity and long life

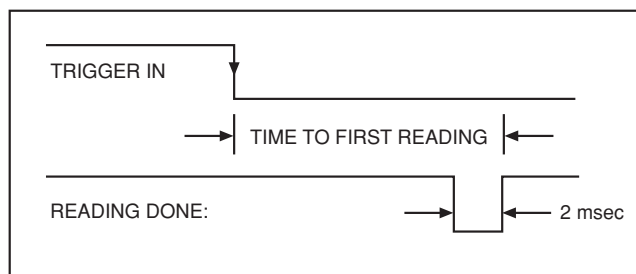
Input Protection

± 15 V continuous. ESD protected per IEC-801-2, Level 1

Overload Current

Delay Mode: 100 % overshoot, <25 μ sec.
Fast Mode: 200 % overshoot, <30 μ sec.

Time to First Reading:



Noise Rejection

60 dB typical at line frequency

Environmental

Operating: 0 °C to +50 °C, <80 % RH;
Storage:
-35 °C to +60 °C, <95 % RH

EMC

CE Class A: EN 55011, IEC; 801-2, IEC801-3

Power

<50 VA, 120/240 VAC ± 10 %

Dimensions

13.3 cm x 21.7 cm x 33.0 cm
(5.2 x 8.5 x 13.0 in) H X W X D

Weight

4.2 kg (9 lb. 4 oz)

Calibration

Full front panel calibration requires no internal adjustments and can be easily achieved on the production floor.



Model 1750

H I G H S P E E D M I C R O O H M M E T E R

Included Accessories

Manual CD P/N 17509-CD
Power Cord P/N 161006600
Kelvin Klip Set P/N 17501
or Spade Lug Adapter P/N 17502

Optional Accessories

Kelvin Klip Set P/N 17501
Kelvin Klips allow you to make solid four-terminal connections to leaded components. This set is provided as a standard accessory with the 1750 and is particularly useful for hand testing resistors. Four-terminal measurement techniques allow precision measurements by avoiding the effects of lead resistance. Gold-plated, hardened beryllium-copper jaws ensure low contact resistance, low thermal emf to copper, high corrosion resistance and long life.

Spade Lug Adapter P/N 17502
Spade Lug Adapter is an optional cable set for the 1750. Instead of clips it has spade lugs for connection to binding posts and peripheral equipment.

Sorting Fixture P/N 17503
Sorting Fixture holds components for test while providing four-terminal connection. Its holding clips rotate 90 degrees to accommodate axial and radial leaded components alike. Holders may also be adjusted from 0.75", (1.90 cm) to 3.0", (7.62 cm) apart allowing use of the fixture with many component sizes and configurations. Terminal contact pressure is also adjustable. Pressure may be reduced for easy insertion of components with small gauge leads. Contacts are gold-plated beryllium-copper.

Kelvin Probes P/N 17504
Kelvin probes allow the measurement of surface resistance. Each probe has two spring loaded pins spaced 1/8" apart. Pins are replaceable.

Male LEMO Connector and Strain Relief P/N 17505
Male LEMO Connector and Strain Relief is an optional accessory that allows you to interface your existing handlers or probe sets to the new 1750 Resistance Measuring System.

Z540 Compliant Calibration
with Certificate and Data for 1750 P/N OPT-Z540



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